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SEMICONDUCTOR



ESD



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GDT



PLED

AON7380-MS

Product specification

Description

The AON7380 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

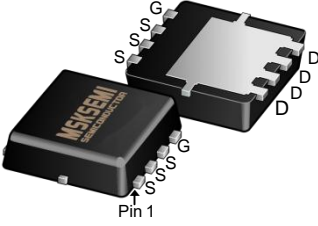
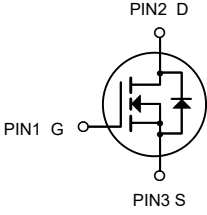

Features

- $V_{DS} = 30V$ $I_D = 35A$
- $R_{DS(ON)} < 10m\Omega$ @ $V_{GS}=10V$

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News

| DFN3X3-8L | N-Channel MOSFET | Marking |
|------------------------------------------------------------------------------------|------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |  |

Absolute Maximum Ratings ($T_c=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Rating | Units |
|-------------------------------|-------------------------------------------------------|------------|--------------------|
| V_{DS} | Drain-Source Voltage | 30 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D @ T_c=25^\circ\text{C}$ | Continuous Drain Current, V_{GS} @ 10V ¹ | 35 | A |
| $I_D @ T_c=100^\circ\text{C}$ | Continuous Drain Current, V_{GS} @ 10V ¹ | 25 | A |
| I_{DM} | Pulsed Drain Current | 112 | A |
| EAS | Single Pulse Avalanche Energy ³ | 24.2 | mJ |
| I_{AS} | Avalanche Current | 22 | A |
| $P_D @ T_c=25^\circ\text{C}$ | Total Power Dissipation ⁴ | 37.5 | W |
| T_{STG} | Storage Temperature Range | -55 to 175 | $^\circ\text{C}$ |
| T_J | Operating Junction Temperature Range | -55 to 175 | $^\circ\text{C}$ |
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient ¹ | 62 | $^\circ\text{C/W}$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case ¹ | 4 | $^\circ\text{C/W}$ |

Electrical Characteristics (T_J=25℃ unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------------|------------------------------------------------|--------------------------------------------------------------------------------------------|------|--------|------|------|
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V, I _D =250uA | 30 | --- | --- | V |
| ΔBV _{DSS} /ΔT _J | BVDSS Temperature Coefficient | Reference to 25℃, I _D =1mA | --- | 0.0193 | --- | V/℃ |
| R _{DS(ON)} | Static Drain-Source On-Resistance ² | V _{GS} =10V, I _D =30A | --- | 7.5 | 10 | mΩ |
| | | V _{GS} =4.5V, I _D =15A | --- | 11 | 18 | |
| V _{GS(th)} | Gate Threshold Voltage | V _{GS} =V _{DS} , I _D =250uA | 1.2 | --- | 2.5 | V |
| ΔV _{GS(th)} | V _{GS(th)} Temperature Coefficient | | --- | -3.97 | --- | mV/℃ |
| I _{DSS} | Drain-Source Leakage Current | V _{DS} =24V, V _{GS} =0V, T _J =25℃ | --- | --- | 1 | uA |
| | | V _{DS} =24V, V _{GS} =0V, T _J =55℃ | --- | --- | 5 | |
| I _{GSS} | Gate-Source Leakage Current | V _{GS} =±20V, V _{DS} =0V | --- | --- | ±100 | nA |
| g _{fs} | Forward Transconductance | V _{DS} =5V, I _D =30A | --- | 34 | --- | S |
| R _g | Gate Resistance | V _{DS} =0V, V _{GS} =0V, f=1MHz | --- | 1.8 | --- | Ω |
| Q _g | Total Gate Charge (4.5V) | V _{DS} =15V, V _{GS} =4.5V, I _D =15A | --- | 9.8 | --- | nC |
| Q _{gs} | Gate-Source Charge | | --- | 4.2 | --- | |
| Q _{gd} | Gate-Drain Charge | | --- | 3.6 | --- | |
| T _{d(on)} | Turn-On Delay Time | V _{DD} =15V, V _{GS} =10V, R _G =3.3Ω I _D =15A | --- | 4 | --- | ns |
| T _r | Rise Time | | --- | 8 | --- | |
| T _{d(off)} | Turn-Off Delay Time | | --- | 31 | --- | |
| T _f | Fall Time | | --- | 4 | --- | |
| C _{iss} | Input Capacitance | V _{DS} =15V, V _{GS} =0V, f=1MHz | --- | 940 | --- | pF |
| C _{oss} | Output Capacitance | | --- | 131 | --- | |
| C _{rss} | Reverse Transfer Capacitance | | --- | 109 | --- | |
| I _S | Continuous Source Current ^{1,5} | V _G =V _D =0V, Force Current | --- | --- | 43 | A |
| I _{SM} | Pulsed Source Current ^{2,5} | | --- | --- | 112 | A |
| V _{SD} | Diode Forward Voltage ² | V _{GS} =0V, I _S =1A, T _J =25℃ | --- | --- | 1 | V |
| t _{rr} | Reverse Recovery Time | I _F =30A, dI/dt=100A/μs, T _J =25℃ | --- | 8.5 | --- | nS |
| Q _{rr} | Reverse Recovery Charge | | --- | 2.2 | --- | nC |

Note :

- 1 .The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3 .The EAS data shows Max. rating . The test condition is V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=22A
- 4.The power dissipation is limited by 175℃ junction temperature
- 5.The data is theoretically the same as I_D and I_{DM}, in real applications , should be limited by total power dissipation.

Typical Characteristics

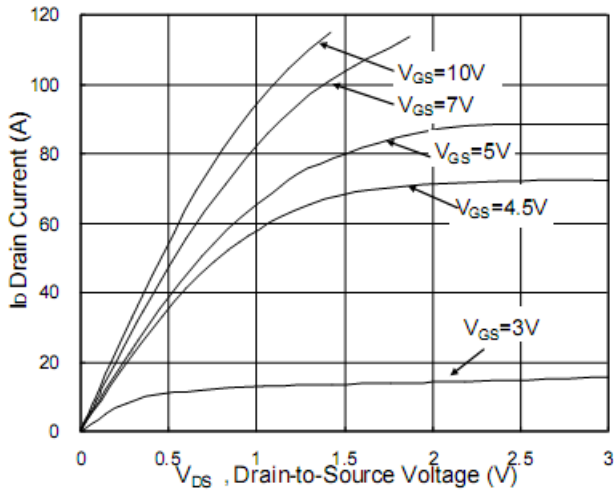


Fig.1 Typical Output Characteristics

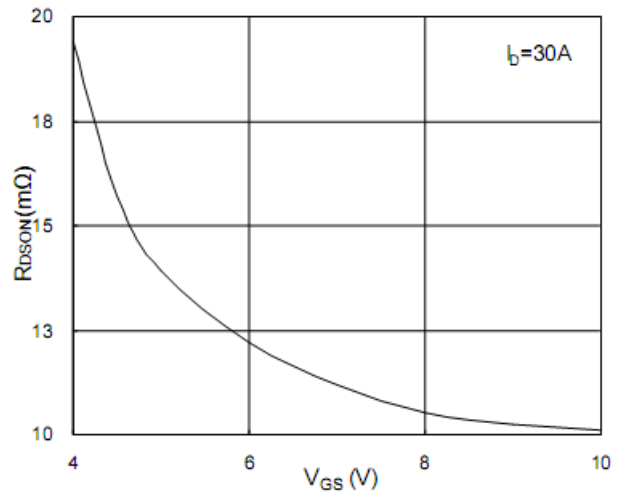


Fig.2 On-Resistance vs. G-S Voltage

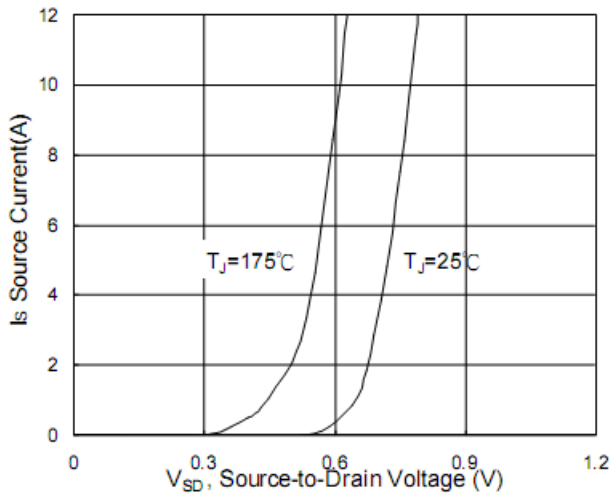


Fig.3 Forward Characteristics of Reverse

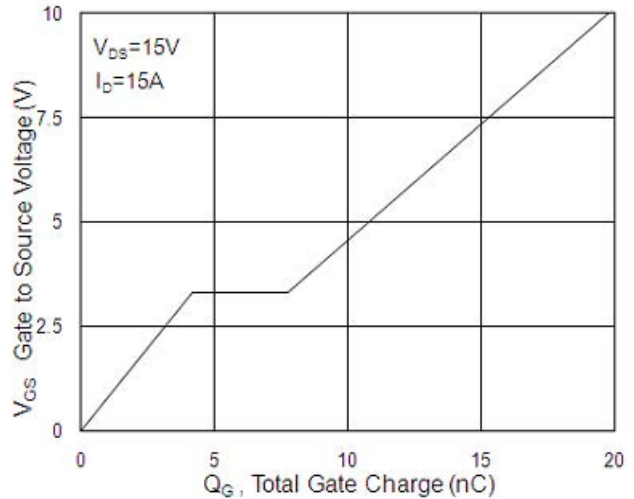


Fig.4 Gate-Charge Characteristics

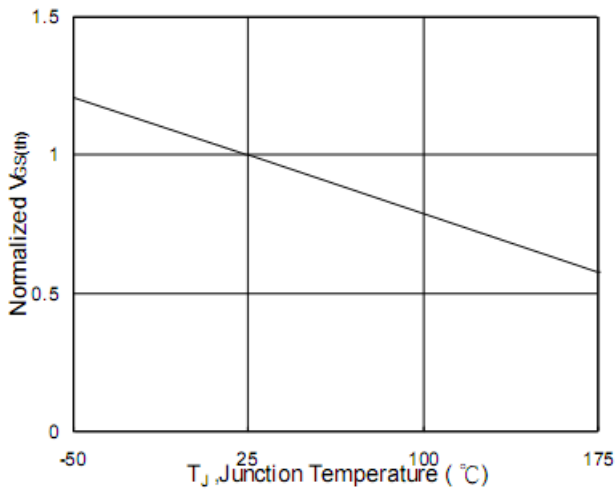


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

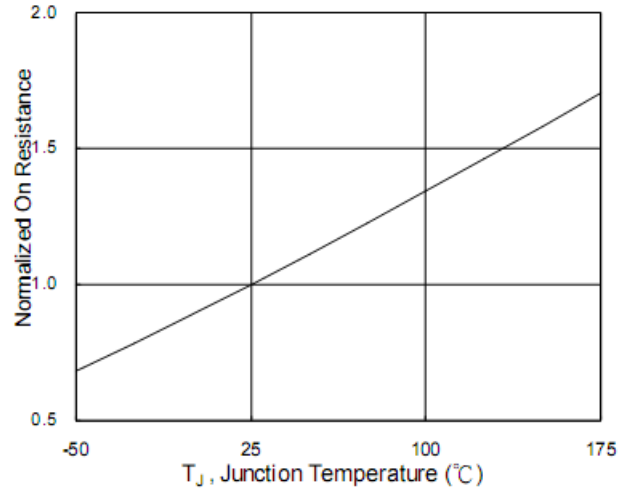


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

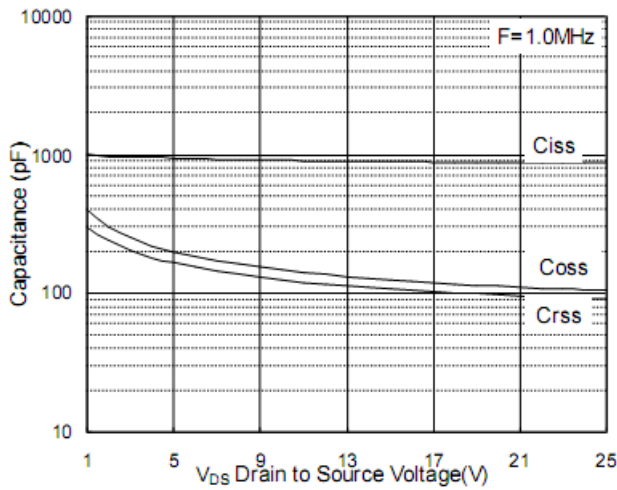


Fig.7 Capacitance

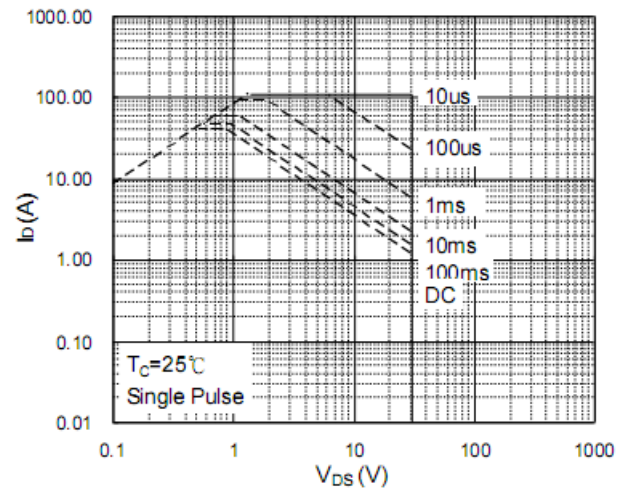


Fig.8 Safe Operating Area

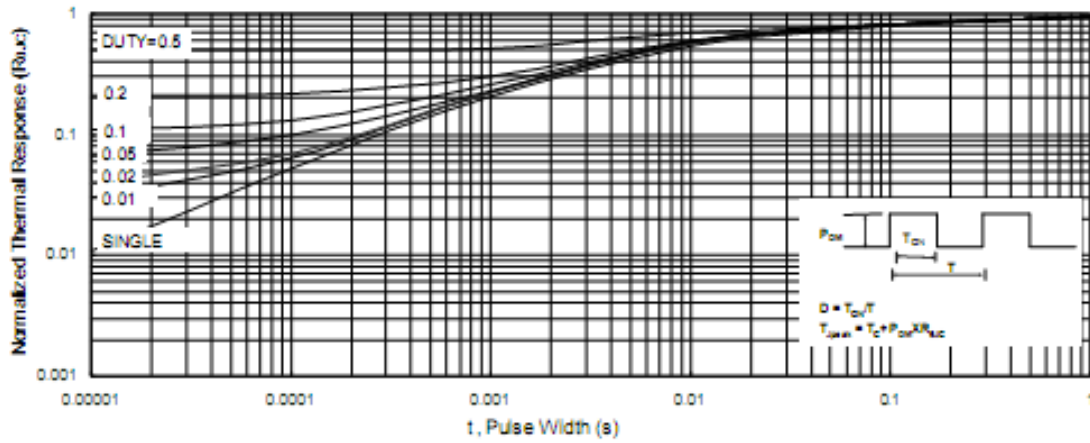


Fig.9 Normalized Maximum Transient Thermal Impedance

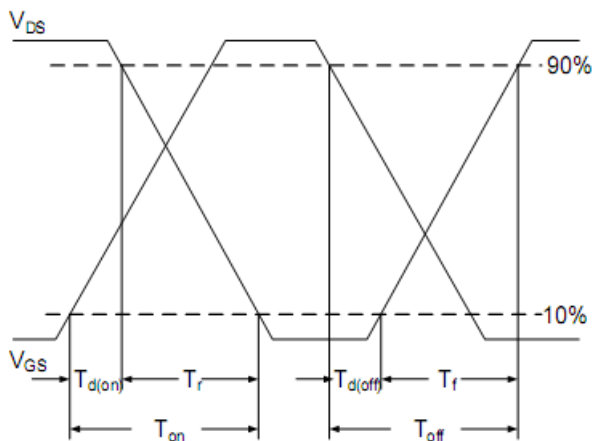


Fig.10 Switching Time Waveform

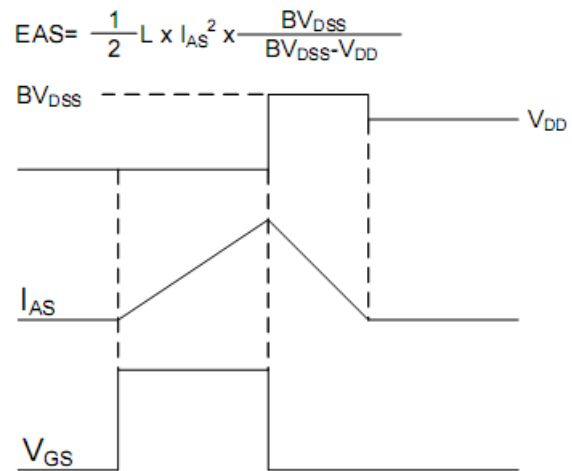
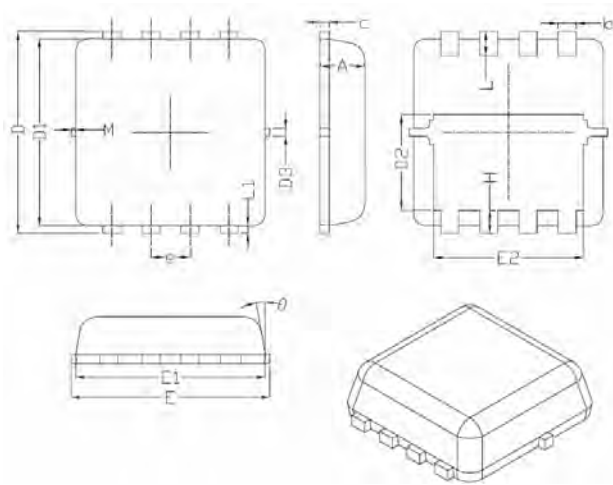


Fig.11 Unclamped Inductive Switching Waveform

$$EAS = \frac{1}{2} L \times I_{AS}^2 \times \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

DFN3X3-8L Package Information



| Symbol | Dimensions In Millimeters | | |
|--------|---------------------------|------|------|
| | Min. | Nom. | Max. |
| A | 0.70 | 0.75 | 0.80 |
| b | 0.25 | 0.30 | 0.35 |
| c | 0.10 | 0.15 | 0.25 |
| D | 3.25 | 3.35 | 3.45 |
| D1 | 3.00 | 3.10 | 3.20 |
| D2 | 1.48 | 1.58 | 1.68 |
| D3 | - | 0.13 | - |
| E | 3.20 | 3.30 | 3.40 |
| E1 | 3.00 | 3.15 | 3.20 |
| E2 | 2.39 | 2.49 | 2.59 |
| e | 0.65BSC | | |
| H | 0.30 | 0.39 | 0.50 |
| L | 0.30 | 0.40 | 0.50 |
| L1 | - | 0.13 | - |
| M | * | * | 0.15 |
| θ | | 10° | 12° |

REEL SPECIFICATION

| P/N | PKG | QTY |
|------------|-----------|------|
| AON7380-MS | DFN3X3-8L | 5000 |

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